

Message Text

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PAGE 01 STATE 122017

11

ORIGIN EB-07

INFO OCT-01 CIAE-00 COME-00 DODE-00 NSAE-00 TRSE-00 EUR-12

ERDA-05 ISO-00 MC-02 (ISO) R

66614

DRAFTED BY: EB/ITP/EWT/LROSS

APPROVED BY: EB/ITP/EWT:RWPRACHT

COMMERCE/OEA-RGAREL

RPE

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R 240105Z MAY 75

FM SECSTATE WASHDC

TO USMISSION OECD PARIS

C O N F I D E N T I A L STATE 122017

EXCON

E.O. 11652: XGDS-1

TAGS: ESTC, COCOM, PL, US

SUBJ: US INSTRUMENTS FOR PRODUCTION TESTING AND
SORTING OF SEMICONDUCTORS-IL 1355

REF: A) COCOM DOC (75)703

B) OECD PARIS 11877

US AUTHORITIES CONSIDER DEVICES IN THIS CASE TO BE COVERED
BY IL 1355(B)(2) AS PARTS FOR A PROBER USED IN TESTING
AND SORTING OF SEMICONDUCTOR CHIPS. HEADING OF IL 1355
COVERS "...PARTS AND SPECIALIZED CONTROLS AND ACCESSORIES"
AND THE DEVICES ARE SPECIALY DESIGNED PARTS AND COMPONENTS
FOR SEMICONDUCTOR PROBE TESTERS WHICH ARE RATED IL 1355
(B)(2) KISSINGER

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NNN

Message Attributes

Automatic Decaptioning: X
Capture Date: 01 JAN 1994
Channel Indicators: n/a
Current Classification: UNCLASSIFIED
Concepts: EXCEPTIONS LIST, IL 1355, SEMICONDUCTOR DEVICES, STRATEGIC TRADE CONTROLS
Control Number: n/a
Copy: SINGLE
Draft Date: 24 MAY 1975
Decaption Date: 01 JAN 1960
Decaption Note:
Disposition Action: RELEASED
Disposition Approved on Date:
Disposition Authority: GarlanWA
Disposition Case Number: n/a
Disposition Comment: 25 YEAR REVIEW
Disposition Date: 28 MAY 2004
Disposition Event:
Disposition History: n/a
Disposition Reason:
Disposition Remarks:
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Document Unique ID: 00
Drafter: EB/ITP/EWT/LROSS
Enclosure: n/a
Executive Order: X1
Errors: N/A
Film Number: D750184-0014
From: STATE
Handling Restrictions: n/a
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ISecure: 1
Legacy Key: link1975/newtext/t19750519/aaaaaqtu.tel
Line Count: 49
Locator: TEXT ON-LINE, ON MICROFILM
Office: ORIGIN EB
Original Classification: CONFIDENTIAL
Original Handling Restrictions: n/a
Original Previous Classification: n/a
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Reference: 75 COCOM DOC (703
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Review Authority: GarlanWA
Review Comment: n/a
Review Content Flags:
Review Date: 16 MAY 2003
Review Event:
Review Exemptions: n/a
Review History: RELEASED <16 MAY 2003 by CunninFX>; APPROVED <03 JUN 2003 by GarlanWA>
Review Markings:

Margaret P. Grafeld
Declassified/Released
US Department of State
EO Systematic Review
05 JUL 2006

Review Media Identifier:
Review Referrals: n/a
Review Release Date: n/a
Review Release Event: n/a
Review Transfer Date:
Review Withdrawn Fields: n/a
Secure: OPEN
Status: NATIVE
Subject: US INSTRUMENTS FOR PRODUCTION TESTING AND SORTING OF SEMICONDUCTORS-IL 1355
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To: OECD PARIS
Type: TE
Markings: Margaret P. Grafeld Declassified/Released US Department of State EO Systematic Review 05 JUL 2006